Search Notes		

<u> </u>	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/218,913	HALL ET AL.
	Examiner	Art Unit
	Nashaat T. Nashed, Ph. D.	1656

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAR)
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STN search, endosed.		11/15/2005	NASH
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